

A flexible parameterization for shortwave optical properties of ice crystals

Bastiaan van Diedenhoven^{1,2}, Andrew Ackerman², Brian Cairns², Ann Fridlind² 1: Columbia University, 2: NASA Goddard Institute for Space Studies **Contact:** bastiaan.vandiedenhoven@nasa.gov



The fundamental radiative properties of atmospheric ice crystals for atmospheric models are the extinction cross section (σ_{e}) , single scattering albedo (ω) and the asymmetry parameter (g). Here, we present a simple, yet accurate parameterization for σ_{e} , ω and g of ice crystals for any combination of

- volume
- projected area
- aspect ratio
- distortion/roughness
- at any wavelength in the shortwave

1: Introduction

Unlike existing parameterizations, this scheme is flexible enough to obtain ice crystal optical properties that are consistent with any assumptions about ice crystal mass (equivalent to bulk volume), projected area and aspect ratio used in modern cloud and climate model ice microphysics schemes to parameterize, e.g., fall-speeds and capacitances of particles.

Main assumptions are:

- Geometric optics are valid
- Optical properties of complex, aggregated ice crystals can be well approximated by those of single hexagonal crystals with varying size, aspect ratio and distortion.
- These assumptions are similar to those of previous parameterizations (e.g., Fu 1996, 2007)



More info: van Diedenhoven et al., A flexible parameterization for shortwave optical properties of ice crystals, J. Atmos. Sci., 2014, doi: 10.1175/JAS-D-13-0205.1.

Get the paper and a python version of the code by scanning the QR code or visit: www.columbia.edu/~bv2154/parameterization.html

2: Reference calculations

- Geometric Optics (GO) code developed by Macke et al. (1996).
- Single hexagonal plates and columns with random orientation
- The distortion parameter represents the stochastic large-scale distortion of a collection of ice crystals.
- Microscale particle surface roughness, crystal impurity and large-scale particle distortion all lead to a similar randomization of the angles between crystal facets (Hess et al. 1998, Yang et al. 2008b). Thus, the distortion used here can be considered as a proxy for the randomization of the angles between crystal facets caused by any of these effects.

3: Single scattering albedo and extinction parameterization

1-2

 $d_e = V/A_p$

4-5

4: Asymmetry parameter parameterization

This diagram shows the steps to obtain the parameterization of asymmetry parameter for particles with any combination of volume, projected area, aspect ratio and distortion and at any wavelength in the shortwave.

A more fundamental parameter is the absorption size parameter χ_{abs} as defined in box 1 of the diagram. The right panel shows that, for a hexagonal particle with aspect ratio α =1, ω in nearly all bands collapse to a single function of χ_{abs} . This function can be parameterized by the formula given in box 2.

The difference $\Delta \omega_{\alpha}$ between $\omega_{\alpha=1}$ at aspect ratio unity and ω at other aspect ratios (see figure) is parameterized as follows:

- 1. For various aspect ratios α , $\Delta \omega_{\alpha}$ is fit by log-normal $\sqrt[3]{0.05}$ functions in χ_{abs} with coefficients I_0 , I_1 , and I_3 .
- 2. Dependence of coefficients I_i on $log(\alpha)$ is fit by polynomial functions for both columns (α >1) and plates (α <1), with coefficient listed in the table.

The total single scattering albedo is the sum of $\omega_{\alpha=1}$ and $\Delta\omega_{\alpha}$. Since we are using geometric optics, the extinction cross section σ_{ρ} is assumed to be twice the orientation-averaged projected area of the particle.

5: Evaluation

Differences with reference calculations for a wide range of particle dimensions are shown in the figures below. Only for bands with strong absorption ($m_i > 0.02$) are substantial errors

SZA=60

• The total asymmetry parameter g_{tot} is computed at 862 nm for various aspect ratios α and distortion values δ (symbols in figure).

- For $\alpha = 1$, the dependence of $g_{\alpha=1}$ on distortion is approximated by a polynomial (black line in figure).
- Differences Δg_{α} between $g_{\alpha=1}$ and the asymmetry parameter at other aspect ratios are approximated by polynomials in δ with coefficients

$p_{\Delta,I}$.

3-5

- Dependence of coefficients $p_{\Delta,i}$ on $\log(\alpha)$ is fit by polynomial functions for both columns and plates, with coefficient listed in the table (colored lines in figure show results).
- The ray tracing asymmetry parameter g_{RT} at 862 nm is obtained by subtracting the diffraction. (g_{dif} = 1 for these calculations).

The dependence of $g_{\rm RT}$ on real refractive index is fit by a function inspired by the Fresnel equation for reflection. Fit parameter ε scales linearly with $log(\alpha)$.

> $\alpha = 0.50, \epsilon = 0.83$ $\alpha = 1.00, \epsilon = 0.96$ --- Fits

For α =1, the dependence of $g_{\rm RT}$ on absorption (C_{ω ,1}) is approximated by polynomial function in $(1-\omega)$ (filled dots and dashed line in top figure).

The relative differences C_{ω_2} between the dependence of

 $(1-\omega)$

